

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/553,984	SATO, HIDEO	
Examiner		Art Unit		Page 1 of 1
John B. King		2435		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,035,398 A	03-2000	Bjorn, Vance	713/186
*	B	US-2001/0034836 A1	10-2001	Matsumoto et al.	713/176
*	C	US-6,317,834 B1	11-2001	Gennaro et al.	713/186
*	D	US-6,363,485 B1	03-2002	Adams et al.	713/186
*	E	US-2002/0040350 A1	04-2002	Shinzaki, Takashi	705/74
*	F	US-2002/0087325 A1	07-2002	Lee et al.	704/270.1
*	G	US-2002/0176583 A1	11-2002	Buttiker, Daniel	380/282
*	H	US-2002/0184509 A1	12-2002	Scheidt et al.	713/185
*	I	US-2003/0005310 A1	01-2003	Shinzaki, Takashi	713/186
*	J	US-2003/0056122 A1	03-2003	Wuidart, Luc	713/202
*	K	US-2003/0103629 A1	06-2003	Wuidart et al.	380/265
*	L	US-2003/0221097 A1	11-2003	Nakano et al.	713/150
*	M	US-2002/0009213 A1	01-2002	Rowe et al.	382/115

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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